Docket No.: 007967 USA/CMP/ECP

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Lawrence C. LEI et al.

Serial No. 10/685,210

Filed: October 14, 2003



Group Art Unit: 2858

Examiner:

For: METHOD AND APPARATUS FOR MEASURING OBJECT THICKNESS

INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Copies of any cited U.S. Patents and U.S. Patent Publications are not being submitted in accordance with 37 CFR 1.98(a)(2)(i).

This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits. No certification or fee is required.

In accordance with 37 C.F.R. § 1.97(g) and (h), the filing of this IDS should not be construed as a representation that a search had been made or that information cited is, or is considered to be, material to patentability as defined in 37 C.F.R.§ 1.56 (b), or that any cited document listed or attached is (or constitutes) prior art. Unless otherwise indicated, the date of Serial No. 10/685,210

publication indicated for an item is taken from the face of the item, and Applicant reserves the right to prove that the date of publication is in fact different.

The references listed on Sheet 1 of the attached PTO-1449 Forms were cited in a PCT application corresponding to the above-referenced application. A copy of the search report for the PCT patent application is also enclosed.

No fee is believed to be required; however, the Commissioner is authorized to charge any deficiency in any fees pursuant to 37 CFR § 1.17 associated with this communication and to credit any excess payment to Deposit Account No. 08-0219.

Respectfully submitted,

WILMER CUTLER PICKERING HALE AND DORR LLP

Scott M. Alter

Registration No. 32,879

1455 Pennsylvania Avenue, NW Washington, DC 20004

TEL 202.942.8400 SMA/lrm

FAX 202.942.8484

Date: 7/15/04

SHEET 1 OF 2

INF	FORMATION I CITATION APPLICA (PTO-14	IN AN ATION 449)	APPLICANT Lawrence C. LI FILING DATE October 14, 200	SERIAL NO. 10/685,210 GROUP 2858				
EXAMINER'S	T T					SUBCLASS DA		
INITIALS	PATENT NO. 4,593,244	06/03/86	Summers et al.	NAME	CLASS	SUBCLASS	08/04/	
	<u></u>	FOI	 REIGN PATENT	T DOCUMENTS	<u>.</u>		4	
EXAMINER'S INITIALS	PATENT NO.	DATE	CC	OUNTRY	CLASS	SUBCLASS	Trans Yes	slation
	WO 01/89765 A1	11/29/01	wo				X	
	DE 4227734 C2	05/15/96	DE				X	
		- 110		itle, Date, Pertinent	Pages, Et	c.)		
	May 21, 2004. Into					No. in the	Desiral	
	Nonaka, Yoshihiro Permeability, and Measurement. Vo	Thickness of	f a Moving Metal	Coil Method for Simu Sheet." IEEE Transa	iltaneously actions on	Measuring the Instrumentation	Resisti n and	vity,
EXAMINER				DATE CONSIDEREI	D			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

	ORMATION I CITATION APPLICA (PTO-1	APPLICANT Lawrence C. LEI et al. FILING DATE October 14, 2003		SERIAL NO. 10/685,210 GROUP 2858				
EXAMINER'S		l	T				FIL	ING
INITIALS	PATENT NO.	DATE]	NAME	CLASS	SUBCLASS	<u> </u>	TE
	2002/0077031 A1	06/20/02	Johansson et al	•			07/06	/01
	6,271,670 B1	08/07/01	Caffey				02/08	/99
	5,534,289	07/09/96	Bilder et al.				01/03	/95
	4,609,870	09/02/86	Lale et al.				09/13	/84
	4,209,744	06/24/80	Gerasimov et a	1.			03/27	/78
	4,207,520	06/10/80 Flora et al.				04/06		/78
		FOR	REIGN PATENT	DOCUMENTS				
EXAMINER'S INITIALS	PATENT NO.	DATE	co	DUNTRY	CLASS	SUBCLASS	Trans Yes	lation No
				 				
						1		
			1			1		
0	OTHER	R ART (Incl	uding Author, T	itle, Date, Pertinent	Pages, Et	c.)		
								
<u> </u>								
							 	
EXAMINER			D	ATE CONSIDEREI)			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.